

<b>Notice of References Cited</b>	Application/Control No. 10/044,490	Applicant(s)/Patent Under Reexamination NAKAMURA ET AL.	
	Examiner Martin J Angebrannt	Art Unit 1756	Page 1 of 2

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	Examiner Martin J Angebrannt	Art Unit 1756	Page 2 of 2

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